


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551521	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAMURA ET AL.
	<b>Examiner</b>  MY-CHAU T TRAN	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	55, 84, 87, 104, 156, 173, 174, 175, 179	08/04/2008	MCT
178	18.01, 18.03, 18.05, 18.06, 18.07, 18.11	08/04/2008	MCT
UPDATED	UPDATED - see printout	12/05/2008	MCT

SEARCH NOTES		
Search Notes	Date	Examiner
PALM Inventors; WEST - see printout	08/04/2008	MCT
UPDATED - see printout	12/05/2008	MCT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
345	87, 104, 173, 175, 179; see printout	12/05/2008	MCT

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